

# AOW25S65-VB Datasheet N-Channel 650V (D-S) Super Junction Power MOSFET

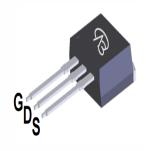
PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650				
R <sub>DS(on)</sub> at 25 °C (Ω)	V <sub>GS</sub> = 10 V 0.160				

### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)

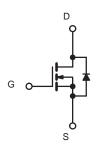
### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- - High-intensity discharge (HID)
  - Fluorescent ballast lighting



TO-262

Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	650	V	
Gate-Source Voltage			$V_{GS}$	± 30		
Continuous Drain Current /T 150 °C)	V <sub>GS</sub> at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	,	20		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	12	Α	
Pulsed Drain Current a			I <sub>DM</sub>	60		
Linear Derating Factor				1.67	W/°C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	950	mJ	
Maximum Power Dissipation			P <sub>D</sub>	165	W	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope T <sub>J</sub> = 125 °C		-1\//-14	50	V/ns		
Reverse Diode dV/dt <sup>d</sup>			dV/dt –			15
Soldering Recommendations (Peak Temperature) c for 10 s		10 s		260	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=100$  V, starting  $T_{J}=25$  °C, L = 30mH,  $R_{g}=25$   $\Omega$ ,  $I_{AS}=13A$ .
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , dI/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



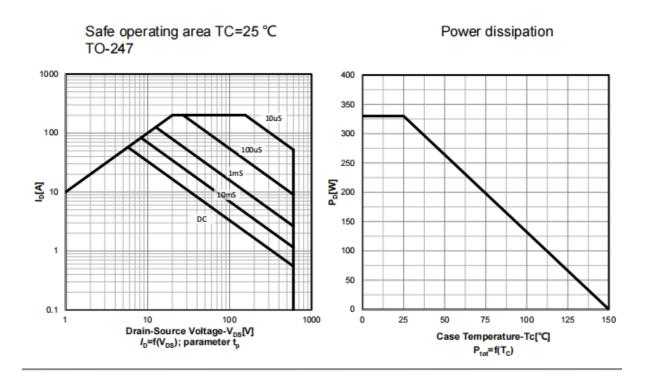
THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. U						
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.38	G/ VV		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•					•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 1 mA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.5	-	4.5	V
			V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Gate-Source Leakage	$I_{GSS}$		V <sub>GS</sub> = ± 30 V	_	-	± 1	μA
			= 650V, V <sub>GS</sub> = 0 V	_	-	1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	_	-	100	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> =7A	-	0.160	-	Ω
Forward Transconductance	9fs	V <sub>DS</sub>	= 30 V, I <sub>D</sub> = 7A	-	5.6	-	S
Dynamic					l	ı	
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 \text{ V},$		2390	-	
Output Capacitance	Coss	1	$V_{DS} = 100 \text{ V},$	-	330	-	1
Reverse Transfer Capacitance	C <sub>rss</sub>	1	f = 1 MHz		4	-	pF
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V		-	63	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	213	-	
Total Gate Charge	Qg				62	-	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 20 \text{ A}, V_{DS} = 520 \text{ V}$		-	39	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	1		-	4 7	-	1
Turn-On Delay Time	t <sub>d(on)</sub>	<u>'</u>		-	18	25	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 520 V, I <sub>D</sub> = 20A,		-	24	55	no
Turn-Off Delay Time	t <sub>d(off)</sub>		, 5 ,	-	8 0	-	ns
Fall Time	t <sub>f</sub>	V <sub>GS</sub> :	$V_{GS}$ = 10 V, $R_g$ = 9.1 $\Omega$		1 2	-	
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		-	0.8	-	Ω
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	_
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	60	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 8 A, V <sub>GS</sub> = 0 V		-	-	1.5	V
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 8 A, dl/dt = 100 A/µs, V <sub>R</sub> = 400 V		_	520	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>			-	5.8	_	μC
Reverse Recovery Current	I <sub>RRM</sub>				4 5		A

### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .





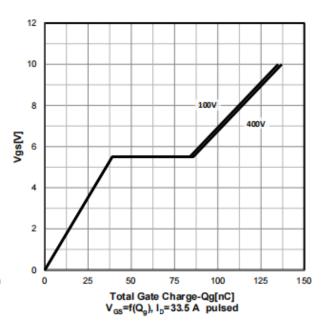
Typ. output characteristics  $T_i$ =25  $^{\circ}$ C Transfer characteristics 300 300 25°C . I<sub>D</sub>, Drain Current [A] Drain Current [A] 200 150°C -0 0 5 10 15 20 0 2 10 12 V<sub>GS</sub>, Gate-Source Voltage [V] V<sub>DS</sub>, Drain to Source Voltage [V]



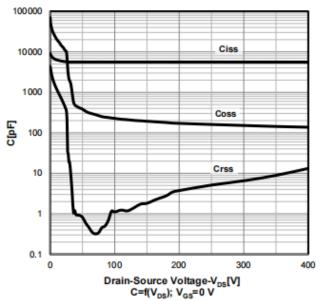
Typ. drain-source on-state resistance

80
70
60
60
40
30
20
0 15 30 45 60 75 90
Drain-Source Current-I<sub>D</sub>[A]
R<sub>DS</sub>(on)=f(I<sub>D</sub>); parameter:V<sub>GS</sub>

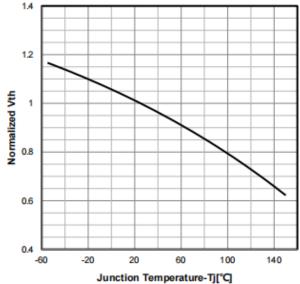
Typ. gate charge characteristics



Typ. capacitances



# Normalized $V_{\text{GS(th)}}$ characteristics

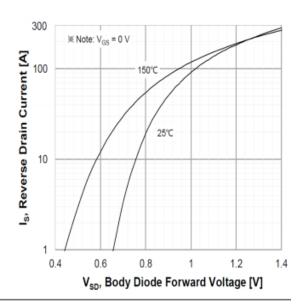




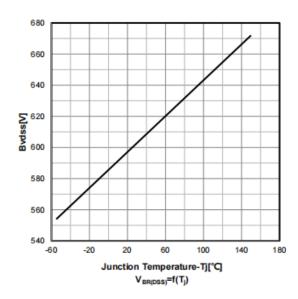
### On-resistance vs temperature

# 120 100 80 60 Max Typ 40 20 0-60 -20 20 60 100 140 180 Junction Temperature-Tj[°C] R<sub>DS</sub>(on)=f(T<sub>j</sub>); I<sub>D</sub>=33.5 A; V<sub>GS</sub>=10 V

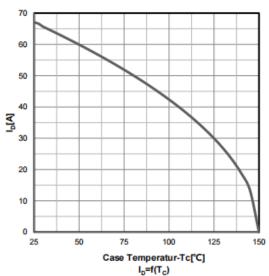
### Forward characteristics of reverse diode



### Drain-source breakdown voltage



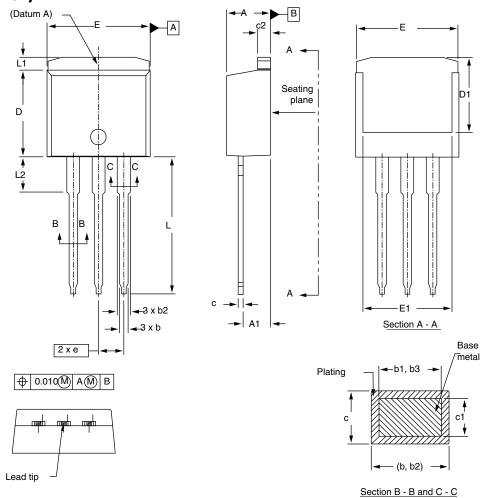
### Drain current vs temperature



服务热线:400-655-8788 5



## I<sup>2</sup>PAK (TO-262)



	MILLIN	METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIM	ETERS	INCI	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54 BSC		0.100 BSC	
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.4
- . Dimension b1 and c1 apply to base metal only.



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
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BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR
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